

COPACK (SiC MOSFETs and SBDs) SOT-227 Power Module

$$V_{CES} = 1200V$$

$$I_D = 100A @ T_C = 100^{\circ}C$$

$$R_{DS_ON} = 12.5 \text{ mohm} @ T_J = 25^{\circ}C$$

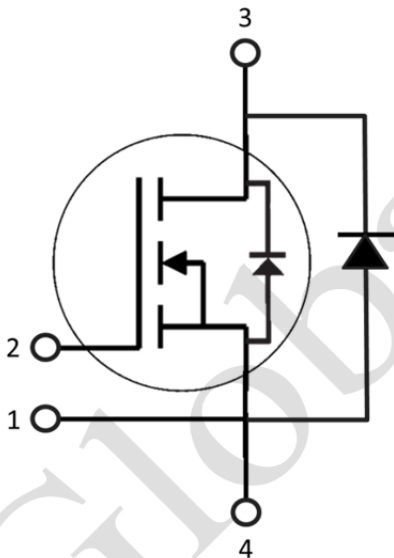


Features

- High speed switching SiC MOSFETs
- Freewheeling diode with zero reverse recovery SiC SBDs
- Low R_{DS_ON}
- Simple to drive
- Kelvin reference for stable gate driving
- High junction temperature operation
- Positive temperature coefficient for easy to parallel mounting

Applications

- Photo Voltaic Inverter
- Aerospace actuators
- Server Power supplies
- High voltage AC/DC Converter
- Motor Drivers



Benefits

- Outstanding power conversion efficiency at high switching frequency operation
- Low switching losses and Low EMI noises
- Very rugged and easy mount
- Direct mounting to heatsink (isolated package)
- Low junction to case thermal resistance
- Easy paralleling due to positive T_c of V_f
- RoHS Compliant

Absolute Maximum Ratings ($T_j=25^{\circ}\text{C}$ unless otherwise specified)

Parameters	Symbol	Conditions	Specifications	Units
SiC MOSFETs				
Maximum Drain-Source Voltage	V_{DSS}	$T_j = 25^{\circ}\text{C} \sim 150^{\circ}\text{C}$	1200	V
Continuous Drain Current	$I_{D(DC)}$	$T_j = 25^{\circ}\text{C}, V_{GS}=20\text{V}$	200	A
		$T_j = 150^{\circ}\text{C}, V_{GS}=20\text{V}$	100	A
Pulse Drain Current	$I_{D(Pulse)}$	$I_D=50\text{A}, V_{DS}=50\text{V}$	250	A
Gate-Source Voltage	V_{GS}		-10/+25	V
SiC SBDs				
Maximum Reverse Voltage	V_{RRM}		1200	V
Average Forward Current	I_{DAV}	$T_j = 25^{\circ}\text{C}$	200	A
		$T_j = 150^{\circ}\text{C}$	100	A
Non-repetitive Forward Surge Current	I_{FSM}	Pulse width t_p limited by T_{jmax}	300	A
COPACK Modules Thermal Properties				
Maximum Power Dissipation	P_D	$T_C = 25^{\circ}\text{C}$	TBD	W
		$T_C = 100^{\circ}\text{C}$	TBD	W
Operating Junction Temperature	T_j		-40 ~ 150	$^{\circ}\text{C}$
Storage Temperature	T_{STG}		-40 ~ 150	$^{\circ}\text{C}$

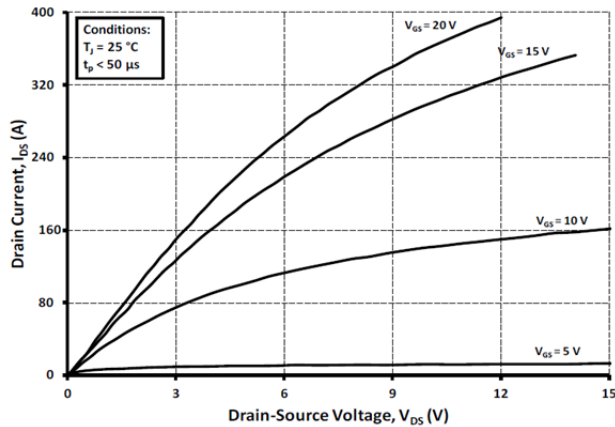
Electrical Characteristics ($T_j=25^{\circ}\text{C}$ unless otherwise specified)

Parameters	Symbol	Conditions	Min	Typ	Max	Units
SiC MOSFETs						
Drain-Source Breakdown Voltage	$V_{(BR)DSS}$	$V_{GS}=0\text{V}, I_D=100\mu\text{A}$	1200	--	--	V
Gate Threshold Voltage	$V_{GS(TH)}$	$V_{DS}=10\text{V}, I_D=10\text{mA}, T_j = 25^{\circ}\text{C}$	1.9	2.3	--	V
		$V_{DS}=10\text{V}, I_D=10\text{mA}, T_j = 150^{\circ}\text{C}$	--	1.6	--	V
Zero Gate Voltage Drain Current	I_{DSS}	$V_{DS}=1200\text{V}, V_{GS}=0\text{V}, T_j = 25^{\circ}\text{C}$	--	4	200	μA
		$V_{DS}=1200\text{V}, V_{GS}=0\text{V}, T_j = 150^{\circ}\text{C}$	--	TBD	TBD	μA
Gate Source Leakage Current	I_{GSS}	$V_{GS}=20\text{V}, V_{DS}=0\text{V}$	--	--	1	μA
Internal Gate Resistance	R_G	$f = 1\text{MHz}, V_{AC} = 25\text{mV}$, per die		1.5		Ω
Drain-Source On-state Resistance	$R_{DS(ON)}$	$V_{GS}=20\text{V}, I_D=100\text{A}, T_j = 25^{\circ}\text{C}$	--	12.5	17	$\text{m}\Omega$
		$V_{GS}=20\text{V}, I_D=100\text{A}, T_j = 150^{\circ}\text{C}$	--	23	32	$\text{m}\Omega$
Trans-conductance	g_{fs}	$V_{DS}=20\text{V}, I_D=100\text{A}, T_j = 25^{\circ}\text{C}$		22		S
		$V_{DS}=20\text{V}, I_D=100\text{A}, T_j = 150^{\circ}\text{C}$		21		
Input Capacitance	C_{ISS}	$V_{GS} = 0\text{V}, V_{DS} = 1000\text{V}$, freq = 1MHz, $V_{AC} = 25\text{mV}$	--	6.0	--	nF
Output Capacitance	C_{OSS}		--	440	--	pF
Reverse transfer Capacitance	C_{RES}		--	46	--	pF

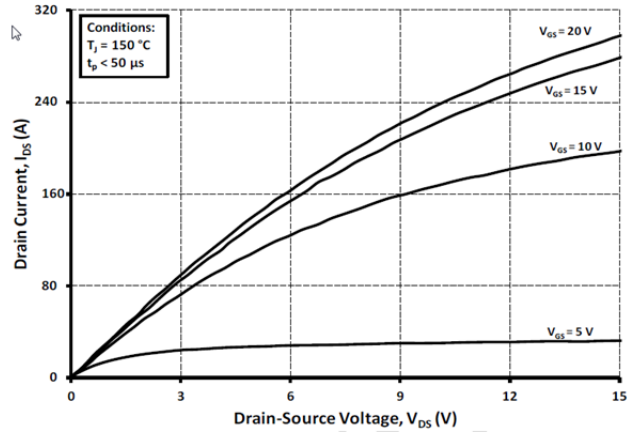
Turn-on Delay Time	$t_{d(on)}$	$V_{DS} = 800V, V_{GS} = -2/20V$ $I_D = 100A, R_{G(ext)} = 1.6\Omega,$ $L = 856\mu H. Refer to definition$	--	25	--	ns	
Rise Time	t_r		--	25	--	ns	
Turn-off Delay Time	$t_{d(off)}$		--	60	--	ns	
Fall Time	t_f		--	35	--	ns	
Turn-on Switching Loss	E_{ON}				TBD		mJ
Turn-off Switching Loss	E_{OFF}				TBD		mJ
Total Gate Charge	Q_g	$V_{CE}=800V, V_{GE} = 0/20V$ $I_D = 80A$	--	360	--	nC	
SiC SBDs							
Maximum peak repetitive reverse voltage	V_{RRM}		1200	--	--	V	
Maximum Reverse Leakage Current	I_{RM}	$V_R = 1200V, T_j = 25^\circ C$	--	16	500	μA	
		$V_R = 1200V, T_j = 150^\circ C$	--	580	--	μA	
Diode Forward Voltage	V_F	$I_F = 100A, T_j = 25^\circ C$	--	1.6	1.8	V	
		$I_F = 100A, T_j = 150^\circ C$	--	2.1	2.6	V	
Total Capacitive Charge	Q_C	$V_R=1200V, I_F < I_{F,max}, di_F/dt = 500$ $A/\mu s, T_j = 25^\circ C$	--	431	--	nC	
Switching Time	t_C	$di_F/dt = 500 A/\mu s, T_j = 25^\circ C$	--	--	10	ns	
Total Capacitance	C	$V_R = 1V, f = 1 MHz$	--	6349	--	pF	
		$V_R = 600V, f = 1 MHz$	--	370	--	pF	
		$V_R = 1200V, f = 1 MHz$	--	359	--	pF	

Thermal and Package Characteristics ($T_j=25^\circ C$ unless otherwise specified)

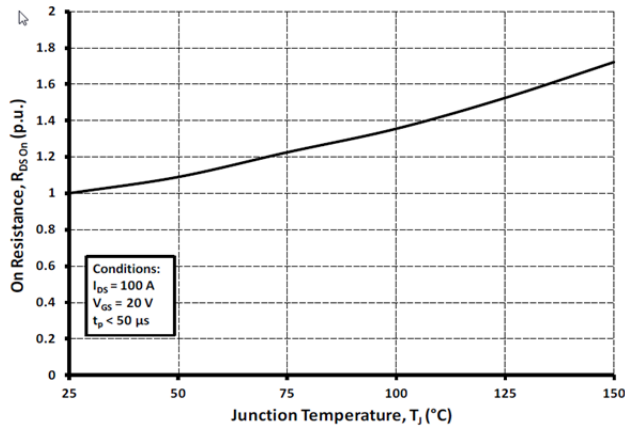
Parameters	Symbol	Conditions	Min	Typ	Max	Units
Junction to Case Thermal Resistance	R_{THJC}	MOSFET (per die)	--	--	0.2	$^\circ C/W$
		SBD (per die)	--	--	0.2	$^\circ C/W$
		Per Module	--	--	TBD	$^\circ C/W$
Junction to Ambient Thermal Resistance	R_{THJA}	Per MOSFET	--	--	TBD	$^\circ C/W$
		Per SBD	--	--	TBD	$^\circ C/W$
		Per Module	--	--	TBD	$^\circ C/W$
Mounting Torque	M_d				1.5	N-m
Terminal Connection Torque	M_{dt}		1.3	--	1.5	N-m
Package Weight	W_t			32		g
Isolation Voltage	V_{ISOL}	$I_{ISOL} < 1mA, 50/60Hz, t=1 min$	2500			V



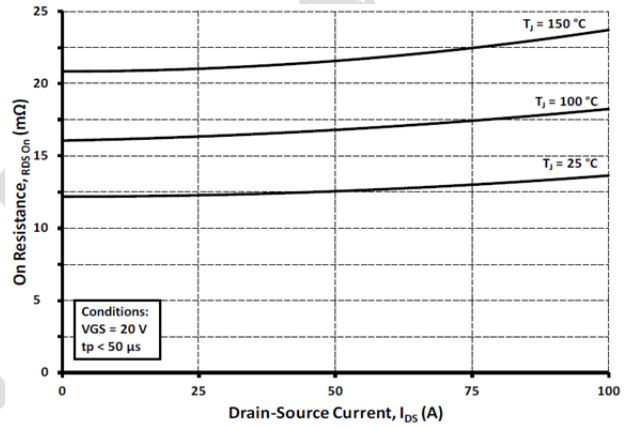
Typical Forward Characteristics T_j=25 °C



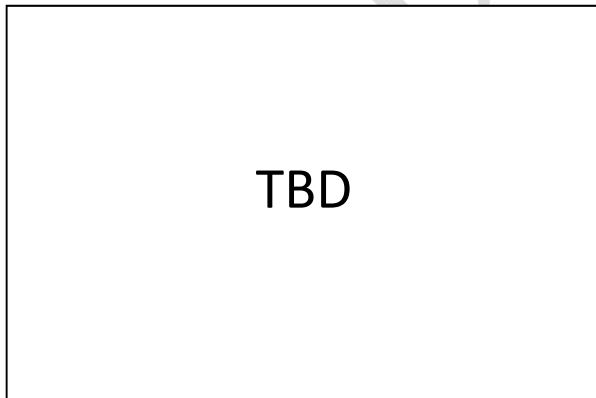
Typical Forward Characteristics T_j=150 °C



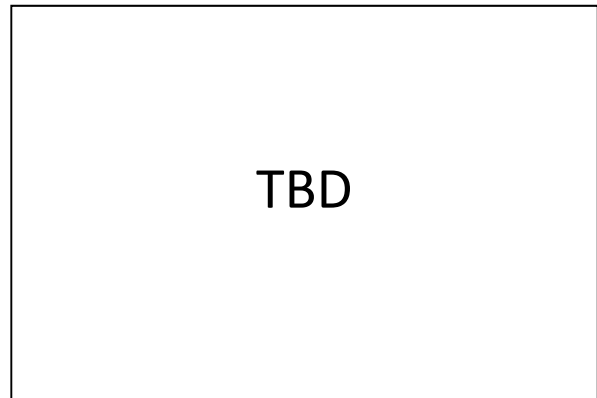
Normalized R_{DS_ON} vs. Temperature



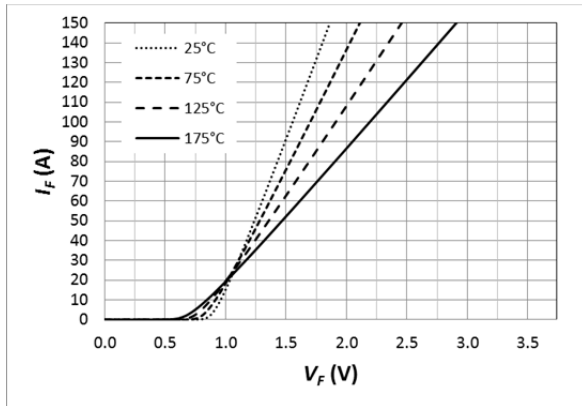
R_{DS_ON} vs. Drain Current



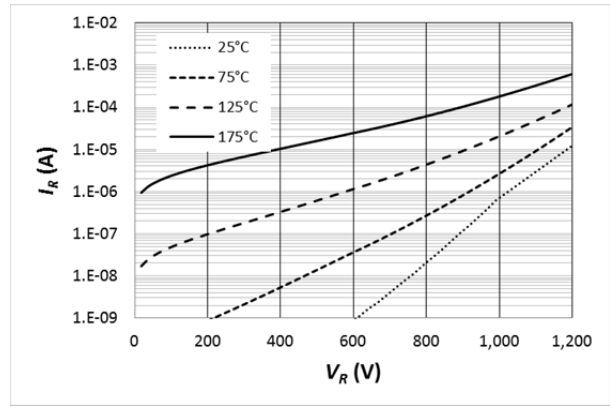
Switching Loss vs. Drain Current



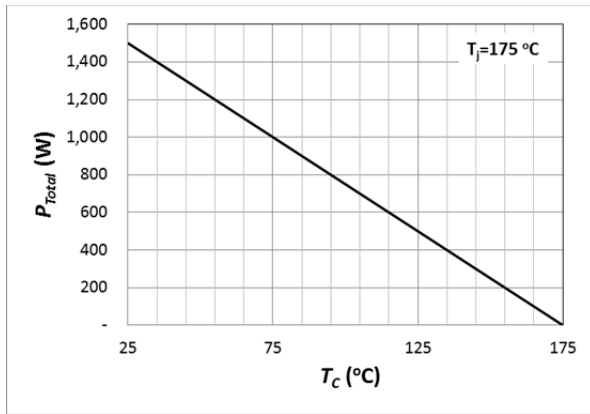
Switching Loss vs. Gate Resistance



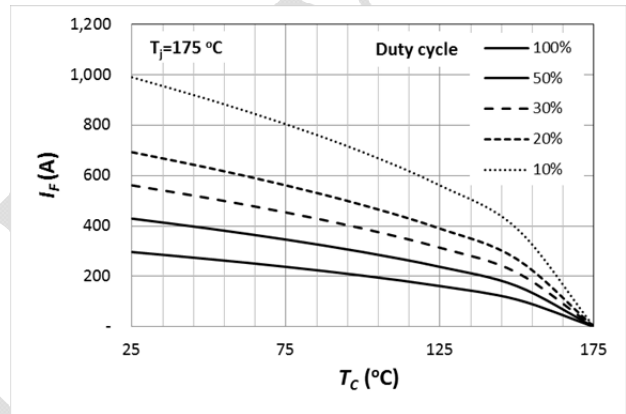
Forward Characteristics (parameterized on Tj)



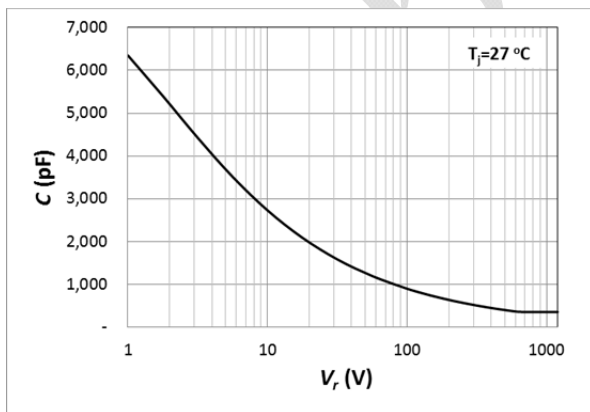
Reverse Characteristics (parameterized on Tj)



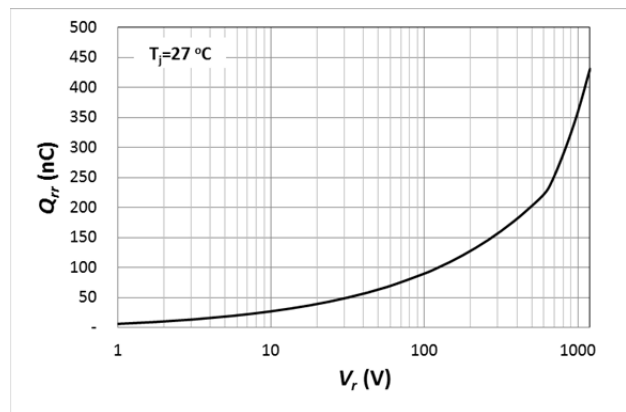
Power Derating



Current Derating



Capacitance Curve



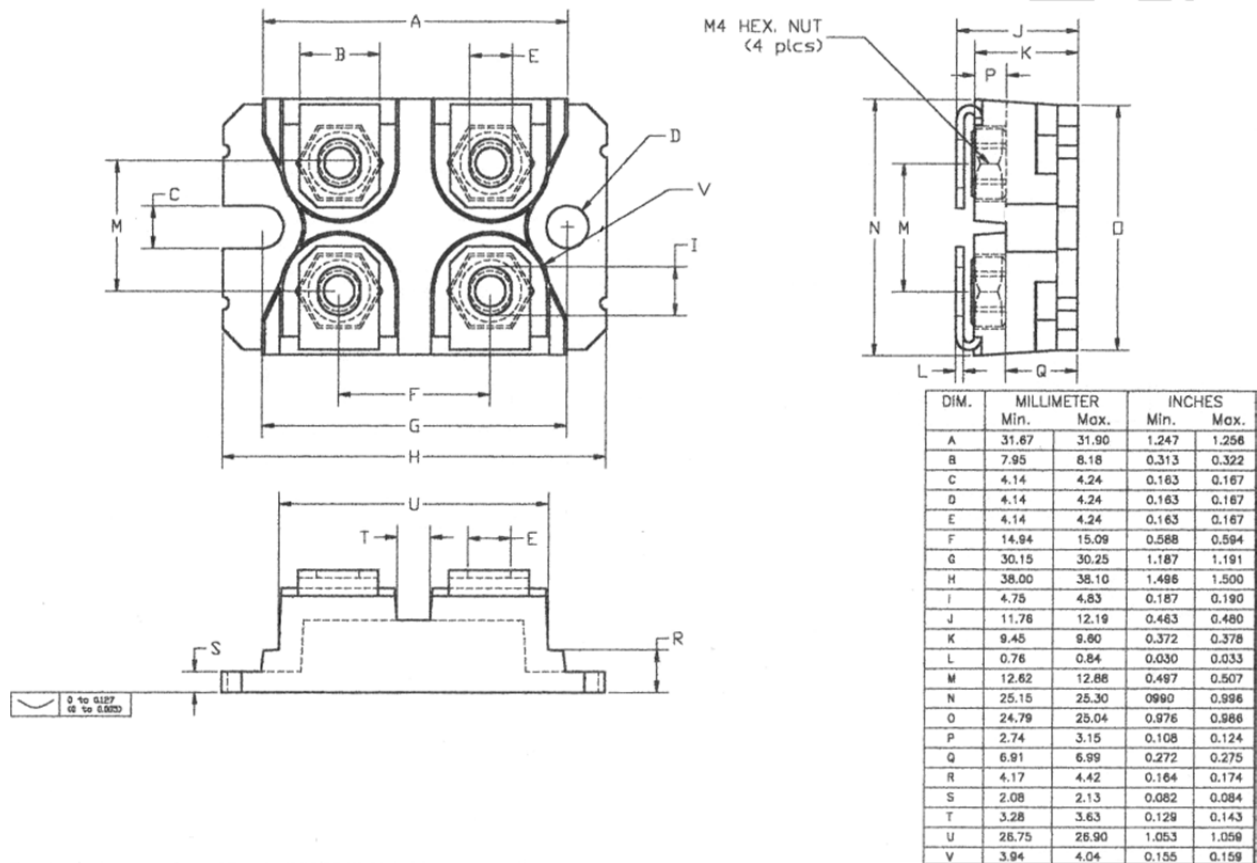
Recovery Charge

Part Number and Pin assignment

Part Number	Rating	Pin 1*	Pin 2	Pin 3	Pin 4*
GCMS012A120S1-E1	1200V, $R_{ds_ON}=12.5$ mohm	Source	Gate	Drain	Source

* pin 1 could be used as a kelvin reference terminal, and pin 4 is assigned for main source power terminal.

SOT-227 Package Outline and Dimension



Revision History

Date	Revision	Notes
02/04/2016	0.1	Initial release

Global Power Technologies Group

20692 Prism Place
Lake Forest, CA 92630
TEL (949) 207-7500
FAX (949) 613-7600
E-mail: info@gptechgroup.com
Web site: www.gptechgroup.com



Notes

- RoHS Compliance**
The levels of RoHS restricted materials in this product are below the maximum concentration values (also referred to as the threshold limits) permitted for such substances, or are used in an exempted application, in accordance with EU Directive 2011/65/EC (RoHS2), as implemented March, 2013. RoHS Declarations for this product can be obtained from the Product Documentation sections of www.gptechgroup.com.
- REACH Compliance**
REACH substances of high concern (SVHCs) information is available for this product. Since the European Chemical Agency (ECHA) has published notice of their intent to frequently revise the SVHC listing for the foreseeable future, please contact our office at GPTG Headquarters in Lake Forest, California to insure you get the most up-to-date REACH SVHC Declaration.
REACH banned substance information (REACH Article 67) is also available upon request.
- This product has not been designed or tested for use in, and is not intended for use in, applications implanted into the human body nor in applications in which failure of the product could lead to death, personal injury or property damage, including but not limited to equipment used in the operation of nuclear facilities, life-support machines, cardiac defibrillators or similar emergency medical equipment, aircraft navigation or communication or control systems, or air traffic control.
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